Search Notes



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Applicant(s)/Patent Under Reexamination

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Art Unit

1794

SEARCHED

Class	Subclass	Date	Examiner
428	408,457, 697, 698, 699, 701 updated	12/09	AAT
502	350 updated	12/09	AAT

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Search Notes	Date	Examiner

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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